

<b>Notice of References Cited</b>	Application/Control No. 10/673,780	Applicant(s)/Patent Under Reexamination KANAI ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,071,014	06-2000	Lee et al.	384/107
	B	US-6,534,890	03-2003	Rafaelof, Menachem	310/91
	C	US-6,836,388	12-2004	Nishimura et al.	360/99.08
	D	US-5,289,067	02-1994	Tanaka et al.	310/90.5
	E	US-6,074,098	06-2000	Asai et al.	384/112
	F	US-6,215,219	04-2001	Hwang, Tae-yeon	310/90.5
	G	US-5,714,828	02-1998	Ackermann et al.	310/90
	H	US-5,841,210	11-1998	Obara, Rikuro	310/90
	I	US-6,618,214	09-2003	Sung et al.	362/293
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 01288611 A	11-1989	Japan	ASADA, TAKAFUMI	F16C 17/02
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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